Gallium Nitride 50V, 100W, 4.4-6GHz RF Power Transistor

Description

The STAV58100G2 is a single ended 100watt, GaN HEMT, ideal for 5G NR applications from 4.8-5GHz and LTE-U application from 5.3-5.9GHz.

It is an internally matched transistor capable of supporting CW, pulse or any modulated signal.

There is no guarantee of performance when this part is used outside of stated frequencies.

• Typical performance across **4.8-5GHz** (On innogration application board with device soldered)

VDD = 48 Vdc, IDQ = 130mA, Tc=25°C

Pulse CW: Pulse width=100us, duty cycle=10%,

| Freq(MHz) | P_1dB(dBm) | P_1dB(W) | P_1dBEff(%) | Gain(p_1dB) | P_3dB(dBm) | P_3dB(W) | P_3dB Eff(%) |
|-----------|------------|----------|-------------|-------------|------------|----------|--------------|
| 4800 | 49.96 | 99.05 | 54.34 | 13.49 | 50.83 | 121.12 | 58.32 |
| 4900 | 49.95 | 90.93 | 54.65 | 14.26 | 50.66 | 116.49 | 58.66 |
| 5000 | 49.23 | 83.69 | 52.86 | 14.06 | 50.53 | 112.94 | 57.21 |

CW:

| Freq(MHz) | Pin(dBm) | Psat(dBm) | Psat(W) | IDS(A) | Gain(dB) | Eff(%) |
|-----------|----------|-----------|---------|--------|----------|--------|
| 4800 | 38 | 50.18 | 104.23 | 4.04 | 12.18 | 51.60 |
| 4900 | 37.93 | 50.1 | 102.33 | 3.93 | 12.17 | 52.08 |
| 5000 | 38.08 | 50.12 | 102.80 | 4 | 12.04 | 51.40 |

• Typical performance across 5.2-5.9GHz (On innogration application board with device soldered)

VDD = 50 Vdc, IDQ = 100mA, Tc=25°C, Pulse CW: Pulse width=100us, duty cycle=10%,

| FREQ | P1dB(dBm) | P1dB(W) | P1dB | P1dB | P3dB(dBm) | P3dB(W) | P3dB |
|-------|-----------|---------|--------|----------|-----------|---------|--------|
| (MHZ) | | | Eff(%) | Gain(dB) | | | Eff(%) |
| 5150 | 49.43 | 87.66 | 56.55 | 12.17 | 50.43 | 110.47 | 57.77 |
| 5250 | 49.54 | 89.94 | 56.03 | 12.44 | 50.67 | 116.65 | 58.25 |
| 5350 | 49.77 | 94.75 | 54.99 | 12.5 | 50.94 | 124.15 | 57.76 |
| 5720 | 49.92 | 98.1 | 51.17 | 13.77 | 51.27 | 134.11 | 55.21 |
| 5800 | 49.71 | 93.46 | 51.13 | 14.49 | 51 | 125.91 | 54.56 |
| 5850 | 49.52 | 89.44 | 51.98 | 13.27 | 50.77 | 119.53 | 55.31 |
| CW: | | | | | | | |
| FREQ | P1dB(dBm) | P1dB(W) | P1dB | P1dB | P3dB(dBm) | P3dB(W) | P3dB |
| (MHZ) | | | Eff(%) | Gain(dB) | | | Eff(%) |
| 5150 | 48.92 | 78.01 | 51.71 | 11.81 | 50.14 | 103.31 | 54.09 |
| 5250 | 49 | 79.52 | 50.93 | 11.88 | 50.29 | 106.74 | 53.91 |
| 5350 | 49.11 | 81.38 | 49.38 | 11.66 | 50.48 | 111.72 | 52.9 |
| 5720 | 48.51 | 70.9 | 43.16 | 13.04 | 50.62 | 115.26 | 50.32 |
| 5800 | 48.96 | 78.71 | 46.16 | 13.58 | 50.5 | 112.25 | 50.52 |
| 5850 | 48.97 | 78.88 | 47.93 | 12.49 | 50.33 | 107.86 | 51.44 |

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Applications

- Sub-6GHz C band pulse or CW amplifier
- 5G or LTE-U Class AB amplifier
- Wideband jammer



Important Note: Proper Biasing Sequence for GaN HEMT Transistors

Turning the device ON

- 1. Set VGS to the pinch--off (VP) voltage, typically –5 V
- 2. Turn on VDS to nominal supply voltage
- 3. Increase VGS until IDS current is attained
- 4. Apply RF input power to desired level

Figure 1: Pin Connection definition

Turning the device OFF

- 1. Turn RF power off
- 2. Reduce VGS down to VP, typically -5 V
- 3. Reduce VDS down to 0 V
- 4. Turn off VGS

Transparent top view (Backside grounding for source)

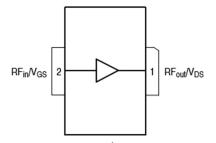


Table 1. Maximum Ratings

| Rating | Symbol | Value | Unit |
|--------------------------------|------------------|-------------|------|
| DrainSource Voltage | V _{DSS} | +200 | Vdc |
| GateSource Voltage | V _{GS} | -8 to +0.5 | Vdc |
| Operating Voltage | V _{DD} | 55 | Vdc |
| Maximum gate current | lgs | 16 | mA |
| Storage Temperature Range | Tstg | -65 to +150 | °C |
| Case Operating Temperature | T _c | +150 | °C |
| Operating Junction Temperature | TJ | +225 | °C |

Table 2. Thermal Characteristics

| Characteristic | Symbol | Value | Unit |
|--|--------------|-------|--------|
| Thermal Resistance, Junction to Case by FEA | D alo | 1.2 | °C /W |
| T _c = 85°C, at Pout=100W, Pulsed CW | Rejc | 1.3 | -0.700 |

Table 3. Electrical Characteristics (TA = 25℃ unless otherwise noted)

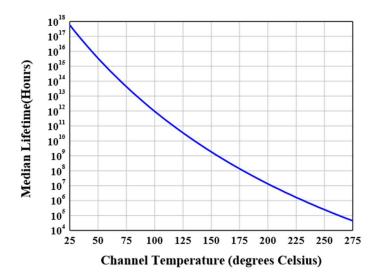
DC Characteristics (measured on wafer prior to packaging)

| Characteristic | Conditions | Symbol | Min | Тур | Max | Unit |
|--------------------------------|---|---------------------|-----|------|-----|------|
| Drain-Source Breakdown Voltage | VGS=-8V; IDS=16mA | V _{DSS} | | 200 | | V |
| Gate Threshold Voltage | VDS =10V, ID = 16mA | V _{GS(th)} | -4 | | -2 | V |
| Gate Quiescent Voltage | VDS =50V, IDS=100mA, Measured in Functional Test | V _{GS(Q)} | | -3.1 | | V |

Ruggedness Characteristics

| Characteristic | Conditions | Symbol | Min | Тур | Max | Unit |
|--------------------------|---|--------|-----|------|-----|------|
| Load mismatch capability | 5.9GHz, Pout=100W pulse CW All phase, No device damages | VSWR | | 10:1 | | |

Figure 2: Median Lifetime vs. Channel Temperature



Typical performance 4.8-5GHz



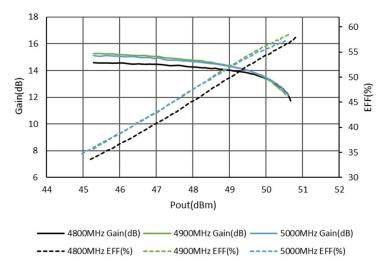


Figure 4: S11 / S21 output from network analyzer on 4.8-5GHz application board

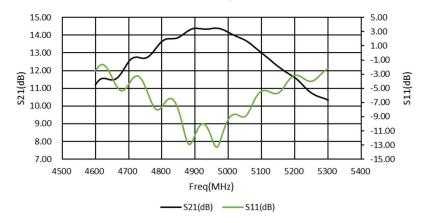
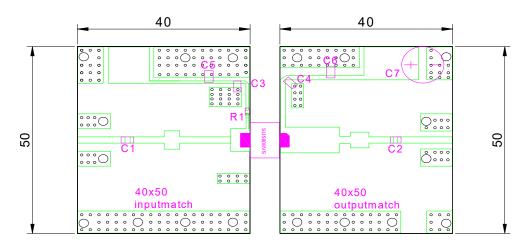


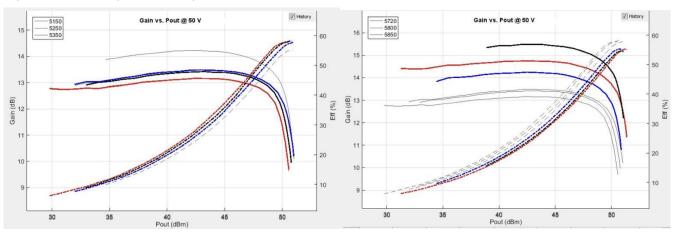
Figure 5: Picture of application board of 4.8-5GHz and bill of materials

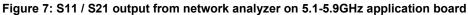


| Component | Description | Suggested |
|-------------|--|-------------------|
| | | Manufacturer |
| C1,C2,C3,C4 | 3.3pF | DLC75D |
| C5,C6 | Ceramic multilayer capacitor, 10uF, 100V | 10uF/100V |
| C7 | 470UF | 63V/470UF |
| R1 | Chip Resistor, 11 Ω ,0603 | |
| РСВ | 0.508mm [0.020"] thick, εr=3.48, Rogers RO43 | 50B, 1 oz. copper |

5.1-5.9GHz







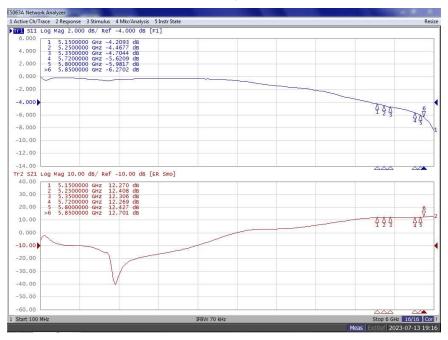
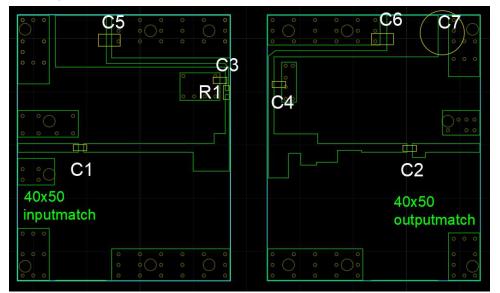


Figure 8: Picture of application board of 5.1-5.9GHz and bill of materials



| Component | Value | Quantity |
|-------------|---------------------------------|--------------------------------|
| U1 | STAV58100G2 | 1 |
| C1、C2、C3、C4 | 3.3pF | 4 |
| C5、C6 | 10uF/63V | 2 |
| R1 | 10 Ω | 1 |
| C7 | 470uF/63V | 1 |
| PCB | 0.508mm [0.020"] thick, εr=3.48 | , Rogers RO4350B, 1 oz. copper |

Package Outline

Flanged ceramic package; 2 leads

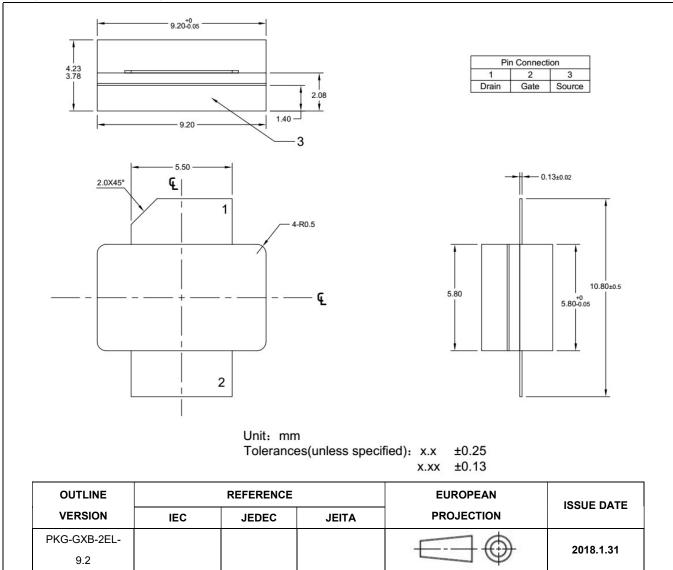


Figure 2. Package Outline PKG-G2

Revision history

Table 4. Document revision history

| Date | Revision | Datasheet Status |
|------------|----------|------------------------------------|
| 2020/12/30 | V1.0 | Preliminary Datasheet Creation |
| 2023/7/13 | V1.1 | Update 5.1-5.9GHz application data |

Application data based on:YHG-20-08/05/ZYX-23-07

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